



YOUSHANG SEMICONDUCTOR

**设计研发新型功率器件**

**各类小信号开关**

**中低压及高压大电流等场效应管**

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## Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ max}$	$I_D \text{ max}$ $T_A = +25^\circ\text{C}$
30V	18m $\Omega$ @ $V_{GS} = 10V$	9.0A
	30m $\Omega$ @ $V_{GS} = 4.5V$	7.0A

## Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage

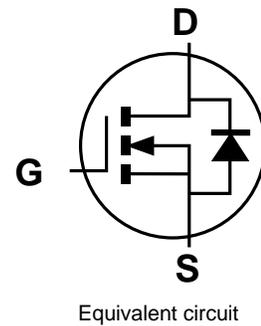
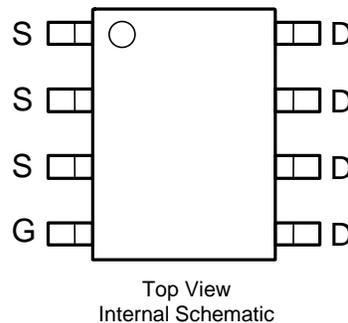
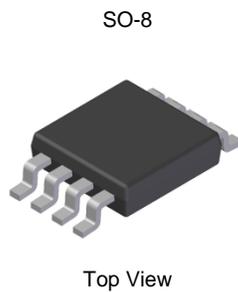
## Description and Applications

This MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

## Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish—Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208  $\text{G3}$
- Weight: 0.074 grams (Approximate)



**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	30	V
Gate-Source Voltage			$V_{GSS}$	$\pm 25$	V
Drain Current (Note 6)	Steady State	$T_A = +25^\circ\text{C}$	$I_D$	9.0	A
		$T_A = +70^\circ\text{C}$		6.75	
Pulsed Drain Current (10 $\mu\text{s}$ Pulse, Duty Cycle = 1%)			$I_{DM}$	40	A

**Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	$P_D$	1.7	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	73	$^\circ\text{C/W}$
Total Power Dissipation (Note 6)	$P_D$	2.5	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	50	$^\circ\text{C/W}$
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 7)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	1	$\mu\text{A}$	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	—	—	$\pm 100$	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
		—	—	$\pm 1$	$\mu\text{A}$	$V_{GS} = \pm 25V, V_{DS} = 0V$
<b>ON CHARACTERISTICS (Note 7)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	1	—	2.1	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(on)}$	—	15.7	18	m $\Omega$	$V_{GS} = 10V, I_D = 9A$
		—	26.4	30		$V_{GS} = 4.5V, I_D = 7A$
Forward Transconductance	$g_{fs}$	—	5.8	—	S	$V_{DS} = 10V, I_D = 9A$
Diode Forward Voltage	$V_{SD}$	0.5	0.7	1.2	V	$V_{GS} = 0V, I_S = 2.1A$
<b>DYNAMIC CHARACTERISTICS (Note 8)</b>						
Input Capacitance	$C_{iss}$	—	741	—	pF	$V_{DS} = 15V, V_{GS} = 0V$ $f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	—	124	—	pF	
Reverse Transfer Capacitance	$C_{rss}$	—	95	—	pF	
Gate Resistance	$R_G$	0.30	0.88	2.5	$\Omega$	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0\text{MHz}$
<b>SWITCHING CHARACTERISTICS (Note 8)</b>						
Total Gate Charge	$Q_g$	—	7.6	12	nC	$V_{DS} = 15V, V_{GS} = 4.5V, I_D = 9A$
		—	16.7	25		$V_{DS} = 15V, V_{GS} = 10V, I_D = 9A$
Gate-Source Charge	$Q_{gs}$	—	1.9	—	ns	$V_{GS} = 10V, V_{DS} = 15V,$ $R_L = 15\Omega, R_G = 6\Omega$
Gate-Drain Charge	$Q_{gd}$	—	5.2	—		
Turn-On Delay Time	$t_{d(on)}$	—	4.0	—		
Rise Time	$t_r$	—	4.4	—		
Turn-Off Delay Time	$t_{d(off)}$	—	23.0	—		
Fall Time	$t_f$	—	9.4	—		

- Notes:
- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
  - Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to product testing.

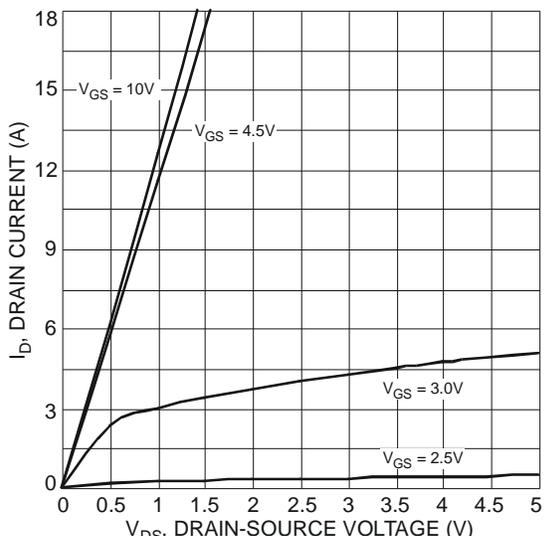


Fig. 1 Typical Output Characteristic

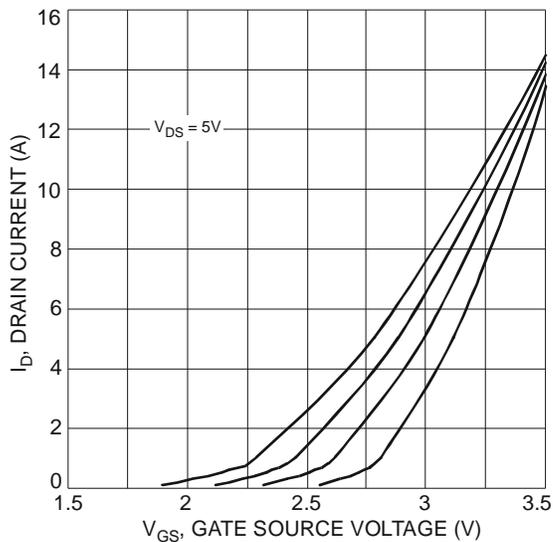


Fig. 2 Typical Transfer Characteristics

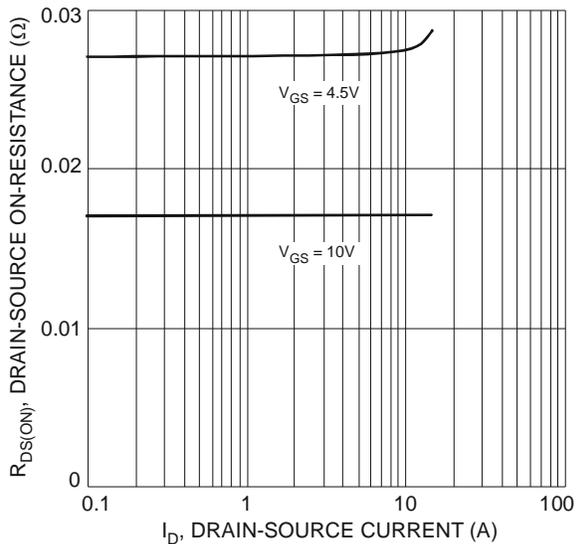


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

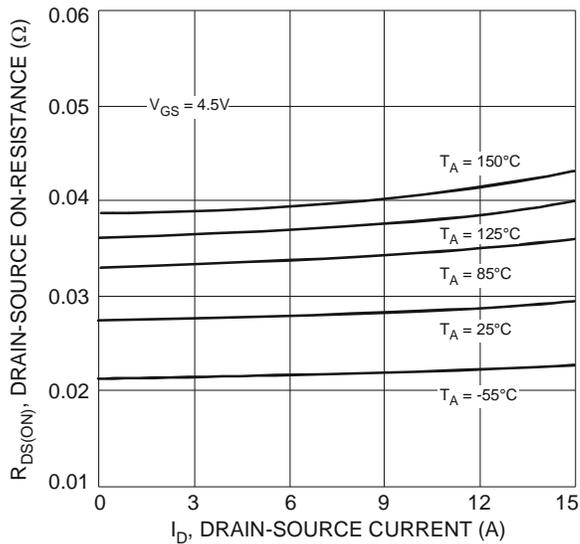


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

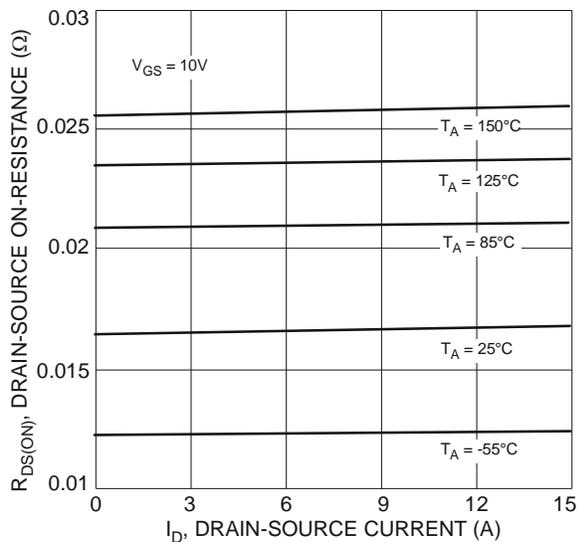


Fig. 5 Typical On-Resistance vs. Drain Current and Temperature

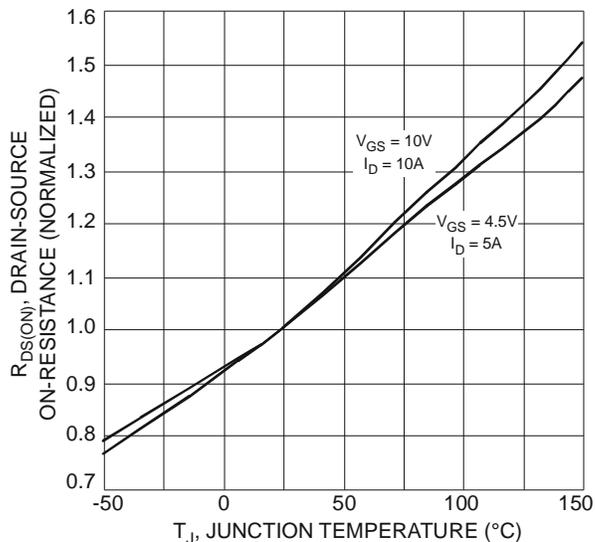


Fig. 6 On-Resistance Variation with Temperature

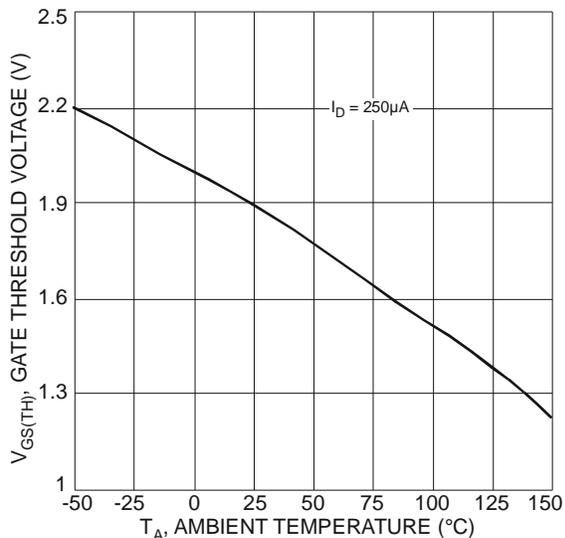


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

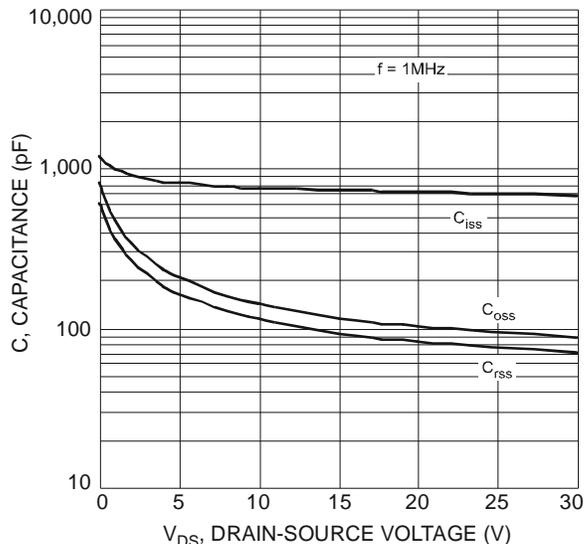


Fig. 8 Total Capacitance

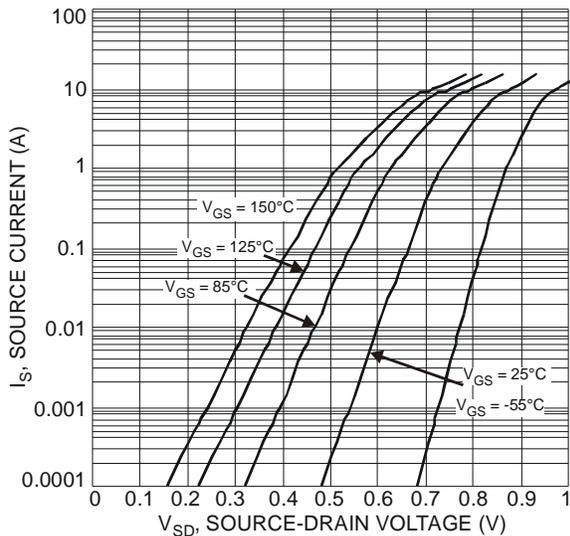


Fig. 9 Diode Forward Voltage vs. Current

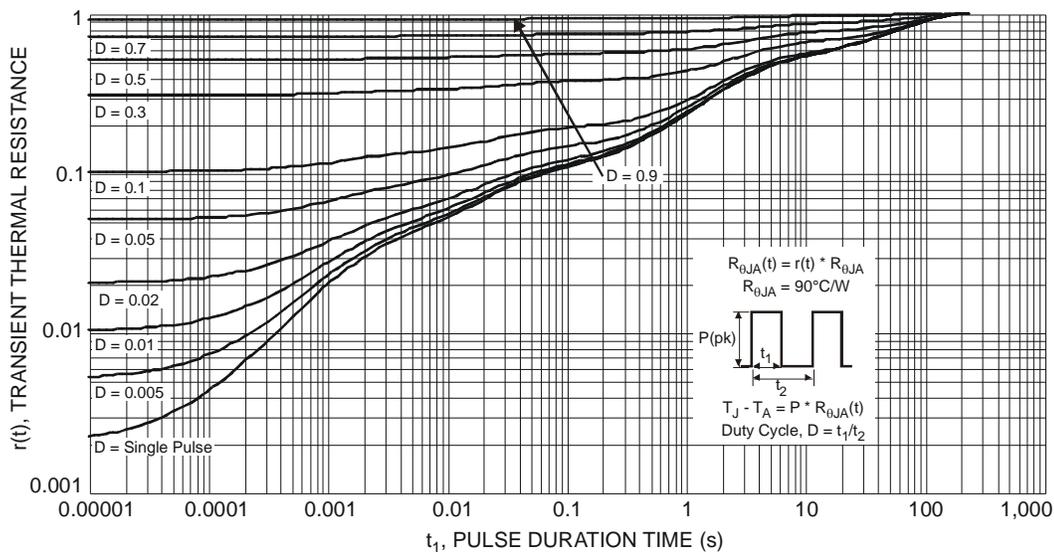
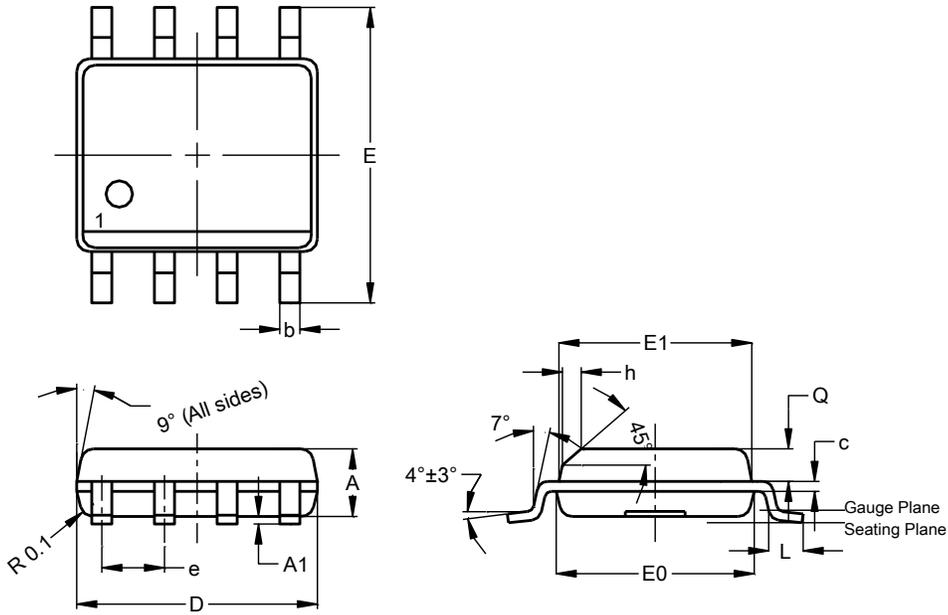


Fig. 10 Transient Thermal Response

**Package Outline Dimensions**

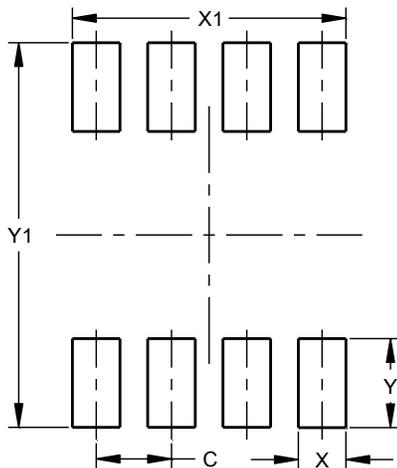
SO-8



SO-8			
Dim	Min	Max	Typ
A	1.40	1.50	1.45
A1	0.10	0.20	0.15
b	0.30	0.50	0.40
c	0.15	0.25	0.20
D	4.85	4.95	4.90
E	5.90	6.10	6.00
E1	3.80	3.90	3.85
E0	3.85	3.95	3.90
e	--	--	1.27
h	-	--	0.35
L	0.62	0.82	0.72
Q	0.60	0.70	0.65
All Dimensions in mm			

**Suggested Pad Layout**

SO-8



Dimensions	Value (in mm)
C	1.27
X	0.802
X1	4.612
Y	1.505
Y1	6.50